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(54) **FDDI bit error rate tester**

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Description

The invention generally relates to methods and apparatus used in Fiber Distributed Data Interface (FDDI) networks to monitor link quality and isolate faults. More particularly, the invention relates to methods and apparatus which monitor bit error rate at the physical (PHY) management layer of the FDDI hierarchy, using existing line status information, to localize and isolate faults

FDDI token ring networks are well known to those skilled in optical data path communications technology. FDDI is a result of American National Standards Committee X3T9 and grew from the need for high speed interconnection among main frames, minicomputers and associated peripherals. It supports a variety of front-end, back-end and backbone networks configured in a variety of topologies and provides for secure 100 and 200 megabit per second transmission across long distance links (e.g., 100 km), with excellent immunity to the effects of electrical radiation and common mode voltages.

In order to appreciate the context in which the novel tester methods and apparatus are used, a brief description of the structure of an FDDI token ring network will first be set forth.

At least part of the rationale behind organizing FDDI as a ring is based on the nature of optical communication. Bus and passive star topologies would require the optical transmission to be detected at several sources simultaneously. Although fiber-optic taps are currently becoming available, the optical attenuation caused by such a device would severly restrict the number of nodes on the network.

Fiber-optic communication is still best suited for point-to-point transmission. Two types of Local Area Network (LAN) topologies can be realized with point-to-point links: the active hub star and the ring. Active stars introduce a single failure point that can disable the entire LAN. Single-ring networks also are prone to failures at any node. FDDI alleviates this problem with the dual-ring approach.

An FDDI ring typically comprises a variety of station types. Class A stations connect to both the primary and secondary rings of the network and are often referred to as "dual attachment stations". Data flows in opposite directions on the two rings. The Class A station can act as a wiring concentrator, serving to interconnect several single-attachment or Class B stations to the ring. Wiring concentrators give the network administrator a single maintenance point for a large number of stations. Class B attacmnents trade lower implementation costs and ease in servicing against the fault tolerance afforded in a Class A station.

The FDDI defined in X3T9 relates to the lower layers of the Open Systems Interconnection/International Organization for Standardization (OSI/ISO) model as follows.

The lowest layer of the OSI model, the Physical Layer, is described in two documents. The first, the FDDI Physical Medium Dependent (PMD) document, details optical specifications for FDDI. PMD defines the wavelength for optical transmission, the fiberoptic connector employed, and the function of the optical receiver. PMD also details an optional optical by-pass switch that can be incorporated within a station.

The second document describes the FDDI Physical Sublayer (PHY) which is the upper sublayer within the OSI Physical Layer. PHY defines the 4B/5B group-encoding scheme used to represent data and control symbols on the network. PHY also describes the method for retiming transmission within the mode.

The Data Link Layer in the OSI model is often subdivided into two sublayers: Link Layer Control (LLC) and Media Access Control (MAC). FDDI defines the lowest of these sublayers, MAC. Among other things, MAC defines the recovery, mechanisms required for FDDI.

Another key element in the FDDI standards is Station Management (SMT). SMT falls outside of the scope of the OSI model and provides the intelligence that allows cohesive operation of the individual sublayers in an FDDI node. SMT defines error detection and fault isolation algorithms.

Having briefly described the structure and components of an FDDI ring it should be clear that physical link integrity needs to be assured. Thus, in high speed token ring networks, it is important to monitor the quality of the physical links on a continuous basis, identify bad links and isolate them. One means of identifying a bad link is to maintain a bit error rate count and exclude a link whenever a threshold of bit error rate, determined by the network manager, is exceeded. This prevents error propagation and insures that network throughput is efficiently maintained.

The FDDI standard has specified certain services in its MAC layer/SMT layer interface for the purpose of monitoring frames with errors or violation symbols. Though it serves as a measure of the quality of the physical connection between adjacent MACs, these services do not monitor an idle ring. Also, these services fail to isolate the fault to a specific physical link if there are many intervening physical links in between adjacent MACs. This situation is bound to happen in a secondary ring with fewer MACs if not all dual attachment stations have two MACs in them. In such cases, a need arises to monitor link quality at the PHY layer level.

Moreover, dual MACs cannot isolate single errors in single attachment stations connected to a concentrator. This is because the MAC at the concentrator sees only the final PHY which attaches to its single attachment station. Though known connection management (CMT) methods and apparatus can take

care of long term noise, these methods and apparatus cannot account for single errors.

For the aforementioned reasons, it would be desirable to be able to continuously monitor link quality at the PHY layer without using the MAC.

European Patent EP-A-0 052 390 (and equivalent US 4 462 099) describes a data transmission system having a plurality of terminal units 10.2-10.4 which are interlinked by input lines 12 and 13. A test circuit in each terminal unit investigates separate copies of test signals to test whether they are free from errors and switches the input from line 12 to line 13 if the error rate is larger than a preset error value.

SUMMARY OF THE INVENTION

Methods and apparatus will be described which provide continuous bit error rate monitoring at the PHY level using existing line status information from PHY. Simple error detection logic, in combination with an error counter and a timer, is used to detect errors during active or idle line state conditions.

We will describe a method (and apparatus for implementing it) which involves counting n bytes of Line State Unknown (LSU) when in Active Line State (ALS) and m bytes of LSU in Idle Line State (ILS), and treating that as one error event for the purpose of continuous link quality monitoring. According to the preferred embodiment of the invention n=4 and m=1.

The only assumptions made in this described method are that the error does not occur as the last byte of a frame and that the error occurs as an LSU. If it occurs as the last or the second last byte, that count is missed. Otherwise all other cases of noise are accounted for. If there is more than one noise event in a frame it is still counted as one noise event. More than one noise event is less likely for a random noise situation.

Further, as we will describe with reference to a preferred embodiment of the invention, Line State (ALS or ILS) signals are used to enable a timer which measures the duration of time over which link quality is being monitored.

The timer can be reset by any of a set of signals including certain signals generated internally by the tester of the invention, system generated signals and other signals generated by encoder/decoder (ENDEC) logic such as described in our US Patent No. 4,703,486.

By way of example, the ENDEC logic generates the HALT, QUIET, MASTER and IDLE line state indicator inputs used by the novel tester (in a manner to be described hereinafter) to monitor bit error rate count over a controlled time interval.

The timer is used in combination with an error counter which accumulates an error event count, periodically stores the count and, on exceeding a predetermined error threshold, signals a bad link. In accordance with the preferred embodiment of the invention, bad link signals are sent to upper layers, outside of a given FDDI station, such as the System's Management Application Process (SMAP) layer. From such a layer control can be exercised to excise a bad link if possible.

The logic for generating error event signals is described in detail hereinafter and can be fabricated using a combination of D flip-flops, AND gates and an OR gate.

The tester of the invention can be located either inside or outside the PHY layer; but preferrably is situated in the Station Management Layer which is parallel to the MAC and PHY layers.

We will describe a method of apparatus perform continuous bit error rate monitoring at the PHY level of an FDDI.

We will describe a method and apparatus to perform said bit rate monitoring using existing line state information available at the PHY layer.

We will describe a tester that can be easily fabricated using low cost, off-the-shelf components.

We will describe a tester that may be installed in the SMT and which provides link status to upper layers such as the SMAP; but which is fully operational if installed in other locations, such as within the PHY layer.

We will describe a method and apparatus which is able to perform continuous bit error rate monitoring at the PHY layer using existing line state information available at the PHY layer, and is comprised of simple, low cost, off-the-shelf components, etc.

The present invention provides apparatus for performing continuous bit error rate monitoring at the physical layer in each node of a Fiber Distributed Data Interface dual token ring network wherein each node in said network also includes a Station Management layer, a Media Access Control layer, a line state signal generator for generating a predetermined set of line state signals under predetermined conditions, and a byte clock signal generator for generating clocking signals, comprising:

(a) tester logic means, coupled to said line state signal generator, for outputting error event signals as a function of a first subset of said set of line state signals which include an Active Line State signal, an Idle Line State signal and a Line State Unknown signal;

(b) resettable error count means, coupled to said tester logic means, enabled whenever an error event signal is output by said tester logic means, for accumulating an error event count wherein said error count means includes means whereby it may be programmed, by inputting a maximum error count input signal, to generate a full count signal whenever the counter is enabled and reaches said maximum error count before being reset; and

(c) resettable timer means, coupled to said line state signal generator and said byte clock signal generator, operable as a function of a second subset of said set of line state signals, for accumulating a measure of the time elapsed from timer means enablement until timer means reset, wherein said timer means includes means whereby it may be programmed, by inputting a maximum elapsed time input signal, to generate a timer expiration signal whenever the timer is enabled and reaches said maximum elapsed time before being reset.

The present invention provides a method for isolating faults in a high speed FDDI token ring network, comprising the steps of:

(a) utilizing line state information at the PHY layer of the FDDI network to detect and signal error events including counting n occurrences of Line State Unknown in Active Line State and counting m occurrences of LSU in Idle line State before signalling an error event;

(b) outputting an error event signal for each detected error event;

(c) providing a predetermined monitoring interval, started as a function of a set of line state signals and ending at a predetermined maximum time thereafter;

(d) counting signalled error events over said predetermined monitoring interval to develop an accumulated error count;

(e) periodically storing said accumulated error count value;

(f) comparing said accumulated error count with a preselected maximum error count value to generate a full count signal when said accumulated error count reaches said preselected maximum error count value;

(g) signalling a bad link to upper FDDI management whenever said accumulated error count equals said maximum error count value before expiration of the monitoring interval.

These and other objects and features of the invention will become apparent to those skilled in the art upon consideration of the following detailed description and the accompanying Drawing, in which like reference designations represent like features throughout the figures.

BRIEF DESCRIPTION OF THE DRAWING

FIG. 1 depicts a typical dual FDDI ring.

FIG. 2 depicts the same FDDI ring as shown in FIG. 1 with an error in the secondary ring between FDDI stations 103 and 104.

FIG. 3a depicts the preferred embodiment of the FDDI bit error rate tester of the invention while FIG. 3b depicts logic suitable for generating error event signals according to the preferred method for generating said signals.

FIG. 4 depicts the timing and event sequence used by the methods taught herein, for generating an error event signal via the hardware shown in FIG. 3 and 3b. More particularly, the timing diagram of FIG. 4 shows an error event being detected, signalled and isolated in FDDI station 103 of FIG. 2 and further shows that the error does not propagate to FDDI station 102 of FIG. 2.

DETAILED DESCRIPTION

FIG. 1 shows the configuration of a typical dual FDDI ring. Stations 101, 102 and 103 are all single MAC dual attachment stations. Station 104 is a dual MAC dual attachment station. Station 105 is a concentrator to which single MAC single attachment stations 106, 107 and 108 are attached. The primary ring is traced by a continuous line, shown as 120 in FIG. 1, and the secondary ring is traced by dotted line 130. The MAC and PHY layers in a given FDDI station are labeled along with the data path through each station being indicated. Finally, the primary and secondary inputs and outputs, to and from each station, are separately labeled.

FIG. 2 shows the same ring where there is a fault in secondary ring 130 at the physical link between station 104 and station 103. Since the secondary ring does not have a connection to MAC in station 103, the MACs lost count mechanism is not able to detect and isolate the error. PHY A of station 103 puts out 4 symbols of HALT when it sees the violation symbol V in the midst of a frame, using its ENDEC transmit line as described in our copending US Patent 4, 835 776 and U.S. Patent Nos. 4,703,486 and 4,692,894 respectively, US 4, 835 776 is hereby incorporated by reference.

Station 102 repeats the same 4 symbols of HALT. The new bit error rate tester in station 103, preferably in the SMT layer (not shown) parallel to the MAC and PHY A and PHY B, alone counts the error and isolates the fault.

FIGS. 3a and 3b show the logic of the FDDI bit error rate tester (BERT). It consists of timer 301, error counter 302, storage device 303 (e.g., a register) and some discrete logic. Timer 301 is used to time the time duration for the error count. The timer value and maximum error count can be programmed by signals on lines 310 and 311 respectively. Whenever Quiet, Halt or Master line state conditions arise, or whenever a reset signal is generated by the system (e.g., the SMAP layer), timer 301 is reset. Timer 301 is also reset by internal BERT signals generated whenever the timer is full or when the error count (to be explained hereinafter) reaches a programmable maximum value. The reset mechanism for counter 301 may be seen with reference to OR gate 350 in FIG. 3a.

The clocking for the logic shown in FIGS. 3a and

3b is a byteclock (BCLK) signal. The timer is enabled during active or idle line state conditions as may be seen with reference to OR gate 375.

Error counter 302 is reset at the same time as timer 301 and is enabled on the occurrence of an error event. An error event is defined to occur (according to the preferred embodiment of the invention) upon the occurrence of 4 consecutive LSU (Line State Unknown) when in Active Line State or upon the occurrence of a single LSU during idle line state conditions.

When timer 301 expires, the error count is stored in register 303 so that at any particular instant, both the previous error count and the current error count is available for the upper management.

The reason 4 bytes of LSU is chosen before an error is flagged is because when a repeat filter repeats 4 symbols of HALT, an idle line state condition is flagged after 3 bytes of LSU. This convention is taught in the incorporated patent application. Hence, only the first node which sees the error, counts the error. All other downstream nodes merely repeat the 4 symbols of HALT. This is shown in FIG. 2 where the 4 H symbols are shown between station 103 and 102, between station 102 and 101, etc. on link 130.

If station 103 did not have the bit error rate tester of the invention, the fault would propagate all the way to station 105's MAC (in the concentrator) in FIG. 2. Hence the fault would not get localized. Clearly the BERT located in station 103 immediately isolates the fault before propagation of the error is possible.

In the case of an ILS condition, the first station seeing the noise byte can count that towards noise count for the purpose of continuous link quality monitoring. Other downstream stations only see the IDLES because of the repeat filter in the noisy station. Hence the fault is again localized for an IDLE ring.

The BERT can signal to the upper management that the link is not usable when the error count exceeds a specified limit within the programmed maximum timer value. This is accomplished via gate 390 shown in FIG. 3a.

The time duration has to be 2.5 times the time interval for which an error estimate is being calculated. This is because there are 16 data symbols, one QUIET, five HALTs, and 4 VIOLATION symbols in the FDDI coding table. Hence the probability of data getting converted to noise is approximately 0.4. The bit error test duration should therefore be increased 2.5 times the normal bit error test duration.

Since the bit error rate limit per link is 2.5 x 10^{-10} which corresponds to a 400 million byte clock duration to check for one error bit, the test duration should be increased by 2.5 times to 1000 million byte clocks to see a violation error symbol. To average this over twice the test duration, the time to check for greater then two errors is 2000 million clock, or 31 bits of counter length. Thus the byte counter (timer) for the preferred embodiment of the invention is 31 bits long.

FIG. 3b shows a combination of D flip-flops, AND gates and an OR gate for signalling an error event to error counter 302 (of FIG. 3a) upon the occurrence of 4 LSUs in the ALS or the occurrence of 1 LSU in the ILS.

FIG. 4 is a timing diagram depicting the operation of station 103 and 102 of FIG. 2 in the face of the fault between station 103 and 104.

The Receive Bus (the link between PHY B and PHY A in station 103) of the ENDEC in PHYB of station 103 is shown, in FIG. 4, to have received the symbols II, JK, DD, VV, non II, non II and XXs (don't care symbols), in the order shown. During the byte clock interval in which the JK delimeter (conventionally used to signal the start of a data packet) is observed by station 103, the ALS output of the ENDEC in PHY B of station 103 goes high. Data (DD) follows and upon recognition of a violation (VV), LSU goes high and ALS goes low. The diagram in FIG. 4 shows the error event being signalled after 4 byte clocks of LSU following the ALS state. This is how the logic depicted in FIG. 3 b operates.

The remaining portion of FIG. 4 shows how station 102 does not have to signal an error, i.e., that the error was indeed isolated at station 103 (again, all with reference to FIG. 2). The Receive Bus for station 102 is shown with II, JK, DD, HH, HH, II, II and don't care symbols on the bus.

The ALS signal generated by the ENDEC in PHY B of station 102 goes high upon seeing the JK delimiter. This stays high until LSU appears. LSU appears on the recognition of a violation symbol such as H, Q or V, as described by the FDDI specification.

For the example shown in FIG. 4, LSU stays high until 4 I symbols appear. After 4 I symbols, ILS goes active. The 4 H symbols followed by a stream of idle symbols is generated by the repeat filter inside PHY A of station 103 as taught in the incorporated patent application. Hence, clearly, no error signal is generated by station 102, the fault having been isolated at station 103.

What has been described are methods and apparatus for monitoring link quality and isolating faults in an FDDI network. These methods and apparatus meet the objectives set forth hereinbefore.

The foregoing description of a preferred embodiment of the novel methods and apparatus has been presented for the purposes of illustration and description only. It is not intended to be exhaustive or to limit the invention to the precise form disclosed, and obviously many modifications and variations are possible in light of the above teaching.

The embodiment and examples set forth herein were presented in order to best explain the principles of the instant invention and its practical application to thereby enable others skilled in the art to best utilize the instant invention in various embodiments and with various modifications as are suited to the partic-

ular use contemplated.

It is intended that the scope of the instant invention be defined by the claims appended hereto.

Claims

1. Apparatus for performing continuous bit error rate monitoring at the physical (PHY) layer in each node of a Fiber Distributed Data Interface (FDDI) dual token ring network wherein each node in said network also includes a Station Management (SMT) layer, a Media Access Control (MAC) layer, a line state signal generator for generating a predetermined set of line state signals under predetermined conditions, and a byte clock signal generator for generating clocking signals, comprising:
   (a) tester logic means, coupled to said line state signal generator, for outputting error event signals as a function of a first subset of said set of line state signals which include an Active Line State (ALS) signal, an Idle Line State (ILS) signal and a Line State Unknown (LSU) signal;
   (b) resettable error count means (302), coupled to said tester logic means, enabled whenever an error event signal is output by said tester logic means, for accumulating an error event count wherein said error count means includes means (311) whereby it may be programmed, by inputting a maximum error count input signal, to generate a full count signal whenever the counter is enabled and reaches said maximum error count before being reset; and
   (c) resettable timer means (301), coupled to said line state signal generator and said byte clock signal generator, operable as a function of a second subset of said set of line state signals, for accumulating a measure of the time elapsed from timer means enablement until timer means reset, wherein said timer means includes means (310) whereby it may be programmed, by inputting a maximum elapsed time input signal, to generate a timer expiration signal whenever the timer is enabled and reaches said maximum elapsed time before being reset.

2. Apparatus as set forth in claim 1 further comprising storage means (303), coupled to said timer and said error count means, for storing said signal indicative of error event count whenever said time expiration signal is generated.

3. Apparatus as set forth in claim 2 further comprising means (390) for detecting a bad link, coupled to said timer and said error count means, which generates a signal indicating a bad link if said full count signal is generated prior to time expiration.

4. Apparatus as set forth in claim 3 wherein said test logic outputs an error event signal upon the occurrence of n LSU signal(s) in the ALS and m LSU signal(s) in the ILS.

5. Apparatus as set forth in claim 4 where n=4 and m=1.

6. Apparatus as set forth in claim 5 wherein said second subset of said set of line state signals comprises a QUIET line state signal, a HALT line state signal and a MASTER line state signal.

7. Apparatus as set forth in claim 6 wherein said timer means is also reset upon the presence of any of a third set of signals comprised of said timer expiration signal, said full count signal and an external system reset signal generated by upper management in the FDDI network.

8. Apparatus as set forth in claim 7 wherein the detection and isolation of a bad link is performed independent of said MAC layer.

9. A method for isolating faults in a high speed FDDI token ring network, comprising the steps of:
   (a) utilizing line state information at the PHY layer of the FDDI network to detect and signal error events including counting n occurrences of Line State Unknown (LSU) in Active Line State (ALS) and counting m occurrences of LSU in Idle line State (ILS) before signalling an error event;
   (b) outputting an error event signal for each detected error event;
   (c) providing a predetermined monitoring interval, started as a function of a set of line state signals and ending at a predetermined maximum time thereafter;
   (d) counting signalled error events over said predetermined monitoring interval to develop an accumulated error count;
   (e) periodically storing said accumulated error count value;
   (f) comparing said accumulated error count with a preselected maximum error count value to generate a full count signal when said accumulated error count reaches said preselected maximum error count value;
   (g) signalling a bad link to upper FDDI management whenever said accumulated error count equals said maximum error count value before expiration of the monitoring interval.

10. A method as set forth in claim 9 wherein n=4 and m=1.

Patentansprüche

1. Gerät zur Durchführung kontinuierlicher Bitfehlerratenüberwachung an der physikalischen (PHY) Schicht in jedem Schaltungspunkt eines faseroptischen verteilten Daten-Interface-(FDDI)-Dual-Tokenring-Netzwerks, wobei jeder Schaltungspunkt in dem Netzwerk auch eine Stationsverwaltungs-(SMT)-Schicht, eine Medienzugriffssteuer-(MAC)-Schicht, einen Leitungszustandssignalgenerator zur Erzeugung eines vorbestimmten Satzes von Leitungszustandssignalen unter vorbestimmten Bedingungen und einen Bytetaktsignalgenerator zur Erzeugung von Taktsignalen aufweist, mit:

(a) einer mit dem Leitungszustandssignalgenerator gekoppelten Prüflogikeinrichtung zur Ausgabe von Fehlerereignissignalen als Funktion einer ersten Teilmenge des Satzes von Leitungszustandssignalen, welche ein Leitung-Aktiv-Zustand-(ALS)-Signal, ein Leitung-Frei-Zustand-(ILS)-Signal und ein Leitungszustand-Unbekannt-(LSU)-Signal umfassen;

(b) einer mit der Prüflogikeinrichtung gekoppelten rücksetzbaren, zum Akkumulieren eines Fehlerereigniszählstands vorgesehenen Fehlerzähleinrichtung (302), die immer dann, wenn von der Prüflogikeinrichtung ein Fehlerereignissignal ausgegeben wird, freigegeben wird, wobei die Fehlerzähleinrichtung eine Einrichtung (311) aufweist, von der sie programmiert werden kann, indem ein Maximal-Fehlerzählstandseingangssignal eingegeben wird, um ein Voll-Zählstandssignal immer dann zu erzeugen, wenn der Zähler freigegeben ist und den Maximal-Fehlerzählstand erreicht, bevor er rückgesetzt wird; und

(c) einer mit dem Leitungszustandssignalgenerator und dem Bytetaktsignalgenerator gekoppelten, als Funktion einer zweiten Teilmenge des Satzes von Leitungszustandssignalen betreibbaren rücksetzbaren Zeitgebereinrichtung (301) zum Akkumulieren eines Maßes der von der Freigabe der Zeitgebereinrichtung an bis zur Rücksetzung der Zeitgebereinrichtung abgelaufenen Zeit, wobei die Zeitgebereinrichtung eine Einrichtung (310) aufweist, von der sie programmiert werden kann, indem ein Maximal-Zeit-Ablaufeingangssignal eingegeben wird, um ein Zeitgeber-Ablaufsignal immer dann zu erzeugen, wenn der Zeitgeber freigegeben ist und die maximal abgelaufene Zeit erreicht, bevor er rückgesetzt wird.

2. Gerät nach Anspruch 1, ferner mit einer mit dem Zeitgeber und der Fehlerzähleinrichtung gekoppelten Speichereinrichtung (303) zum Speichern des einen Fehlerereigniszählstand anzeigenden Signals immer dann, wenn das Ablaufsignal erzeugt wird.

3. Gerät nach Anspruch 2, ferner mit einer mit dem Zeitgeber und der Fehlerzähleinrichtung gekoppelten Einrichtung (390) zum Ermitteln einer schlechten Verbindung, die ein eine schlechte Verbindung anzeigendes Signal erzeugt, wenn das Voll-Zählstandssignal vor dem Ablauf der Zeit erzeugt wird.

4. Gerät nach Anspruch 3, bei dem die Prüflogik beim Auftreten von n LSU-Signal(en) in dem ALS-Zustand und m LSU-Signal(en) in dem ILS-Zustand ein Fehlerereignissignal ausgibt.

5. Gerät nach Anspruch 4, wobei n = 4 und m = 1 ist.

6. Gerät nach Anspruch 5, bei dem die zweite Teilmenge des Satzes von Leitungszustandssignalen ein QUIET-Leitungszustandssignal, ein HALT-Leitungszustandssignal und ein MASTER-Leitungszustandssignal aufweist.

7. Gerät nach Anspruch 6, bei dem die Zeitgebereinrichtung auch beim Vorhandensein irgendeines eines dritten Satzes von Signalen, der aus dem Zeitgeberablaufsignal, dem Voll-Zählstandssignal und einem von der oberen Verwaltung in dem FDDI-Netzwerk erzeugten Externsystem-Rücksetzsignal besteht, rückgesetzt wird.

8. Gerät nach Anspruch 7, bei dem die Ermittlung und Isolierung einer schlechten Verbindung unabhängig von der MAC-Schicht durchgeführt wird.

9. Verfahren zum Isolieren von Fehlern in einem Hochgeschwindigkeits-FDDI-Tokenring-Netzwerk, mit den folgenden Schritten:

(a) Verwenden von Leitungszustandsinformation an der PHY-Schicht des FDDI-Netzwerks zum Ermitteln und Signalisieren von Fehlerereignissen einschließlich Zählen des n-maligen Auftretens von unbekanntem Leitungszustand (LSU) im Leitung-Aktiv-Zustand (ALS) und Zählen des m-maligen Auftretens von LSU im Leitung-Frei-Zustand vor dem Signalisieren eines Fehlerereignisses;

(b) Ausgeben eines Fehlerereignissignals für jedes ermittelte Fehlerereignis;

(c) Bereitstellen eines vorbestimmten Über-

wachungsintervalls, das als Funktion eines Satzes von Leitungszustandssignalen beginnt und nach einer vorbestimmten Maximalzeit danach endet;
(d) Zählen der signalisierten Fehlerereignisse über dieses vorbestimmte Überwachungsintervall zur Entwicklung eines akkumulierten Fehlerzählstands;
(e) periodisches Speichern des akkumulierten Fehlerzählstandwerts;
(f) Vergleichen des akkumulierten Fehlerzählstands mit einem vorgewählten Maximal-Fehlerzählstandwert zur Erzeugung eines Voll-Zählstandssignals, wenn der akkumulierte Fehlerzählstand den vorgewählten Maximal-Fehlerzählstandwert erreicht;
(g) Signalisieren einer schlechten Verbindung an die obere FDDI-Verwaltung immer dann, wenn der akkumulierte Fehlerzählstand gleich dem Maximal-Fehlerzählstandwert ist, bevor das Überwachungsintervall abgelaufen ist.

10. Verfahren nach Anspruch 9, bei dem n = 4 und m = 1 ist.

Revendications

1. Dispositif pour effectuer la surveillance continue du taux d'erreurs sur des binaires au niveau de la couche physique (PHY) dans chaque noeud d'un réseau à passage de jeton à interface de données distribuées par fibres optiques (réseau FDDI) dans lequel chaque noeud dudit réseau comprend en outre une couche de gestion du réseau (SMT), une couche de commande d'accès au milieu de transmission (MAC), un générateur de signaux d'état de ligne pour produire un ensemble prédéterminé de signaux d'état de ligne dans des conditions prédéterminées, et un générateur de signaux d'horloge à multiplets pour produire des signaux de cadencement, comprenant :
(a) des moyens logiques de testeur connectés audit générateur de signaux d'état de ligne pour fournir des signaux d'événements d'erreur en fonction d'un premier sous-ensemble dudit ensemble de signaux d'état de ligne, qui comprend un signal d'état de ligne active (ALS), un signal d'état de ligne inactive (ILS) et un signal d'état de ligne inconnu (LSU);
(b) des moyens de compte d'erreurs à remise à l'état initial (302) connectés auxdits moyens logiques de testeur, validés chaque fois qu'un signal d'événement d'erreur est fourni par lesdits moyens logiques de testeur, pour accumuler un compte d'événements d'erreur, dans lesquels lesdits moyens de compte d'erreur comprennent des moyens (311) par lesquels ils peuvent être programmés en introduisant un signal d'entrée de compte maximal d'erreurs pour produire un signal de compte complet chaque fois que le compteur est validé et atteint le compte maximal d'erreurs avant d'être remis à l'état initial; et
(c) des moyens de temporisateur à remise à l'état initial (301) connectés audit générateur de signaux d'état de ligne et audit générateur de signal d'horloge à multiplets, actionnables en fonction d'un deuxième sous-ensemble desdits signaux d'état de ligne pour accumuler une mesure du temps écoulé depuis la validation des moyens de temporisateur jusqu'à la remise à l'état initial des moyens de temporisateur, dans lesquels lesdits moyens de temporisateur comprennent des moyens (310) par lesquels ils peuvent être programmés en leur appliquant un signal d'entrée de temps écoulé maximal pour produire un signal d'expiration de temporisateur chaque fois que le temporisateur est validé et atteint ledit temps écoulé maximal avant d'être remis à l'état initial.

2. Dispositif selon la revendication 1, comprenant en outre des moyens de mémorisation (303) connectés audit temporisateur et auxdits moyens de compte d'erreurs pour mémoriser ledit signal indicatif de compte d'événements d'erreur chaque fois que ledit signal d'expiration de temps est produit.

3. Dispositif selon la revendication 2, comprenant en outre des moyens (390) pour détecter une liaison mauvaise, connectés audit temporisateur et auxdits moyens de compte d'erreurs, qui produisent un signal indiquant une liaison mauvaise si ledit signal de compte complet est produit avant l'expiration du temps.

4. Dispositif selon la revendication 3, dans lequel ladite logique de testeur fournit un signal d'événement d'erreur lors de l'apparition de n signaux LSU dans l'ALS et m signaux LSU dans l'ILS.

5. Dispositif selon la revendication 4, dans lequel n=4 et m=1.

6. Dispositif selon la revendication 5, dans lequel ledit deuxième sous-ensemble dudit ensemble de signaux d'état de ligne comprend un signal d'état de ligne QUIET, un signal d'état de ligne HALT et un signal d'état de ligne MASTER.

7. Dispositif selon la revendication 6, dans lequel

lesdits moyens de testeur sont également remis à l'état initial en présence d'un signal quelconque parmi un ensemble de trois signaux comprenant ledit signal d'expiration de temps, ledit signal de compte complet et un signal extérieur de remise à l'état initial du système produit par des moyens de gestion supérieurs dans le réseau FDDI.

8. Dispositif selon la revendication 7, dans lequel la détection et l'isolement d'une liaison mauvaise sont effectuées indépendamment de ladite couche MAC.

9. Procédé pour isoler des défauts dans un réseau à passage de jeton du type FDDI à grande vitesse de transmission, comprenant les étapes consistant à:

(a) utiliser des informations d'état de ligne au niveau de la couche PHY du réseau FDDI pour détecter et signaler des événements d'erreur, y compris le comptage de n apparitions de l'état de ligne inconnu (LSU) dans l'état de ligne active (ALS) et compter m apparitions de LSU dans l'état de ligne inactive (ILS) avant de signaler un événement d'erreur;

(b) fournir un signal d'événement d'erreur pour chaque événement d'erreur détecté;

(c) prévoir un intervalle de surveillance prédéterminé commençant en fonction d'un ensemble de signaux d'état de ligne et finissant ensuite après un temps maximal prédéterminé;

(d) compter les événements d'erreur signalés dans ledit intervalle prédéterminé de surveillance pour produire un compte d'erreurs accumulées;

(e) mémoriser périodiquement ladite valeur de compte d'erreurs accumulées;

(f) comparer ledit compte d'erreurs accumulées à une valeur maximale présélectionnée de compte d'erreurs pour produire un signal de compte complet lorsque ledit compte d'erreurs accumulées atteint ladite valeur maximale présélectionnée de compte d'erreurs;

(g) signaler une liaison mauvaise aux moyens supérieurs de gestion de réseau FDDI chaque fois que ledit compte d'erreurs accumulées est égal à ladite valeur maximale présélectionnée de compte d'erreurs avant l'expiration de l'intervalle de surveillance.

10. Procédé selon la revendication 9, dans lequel n=4 et m=1.

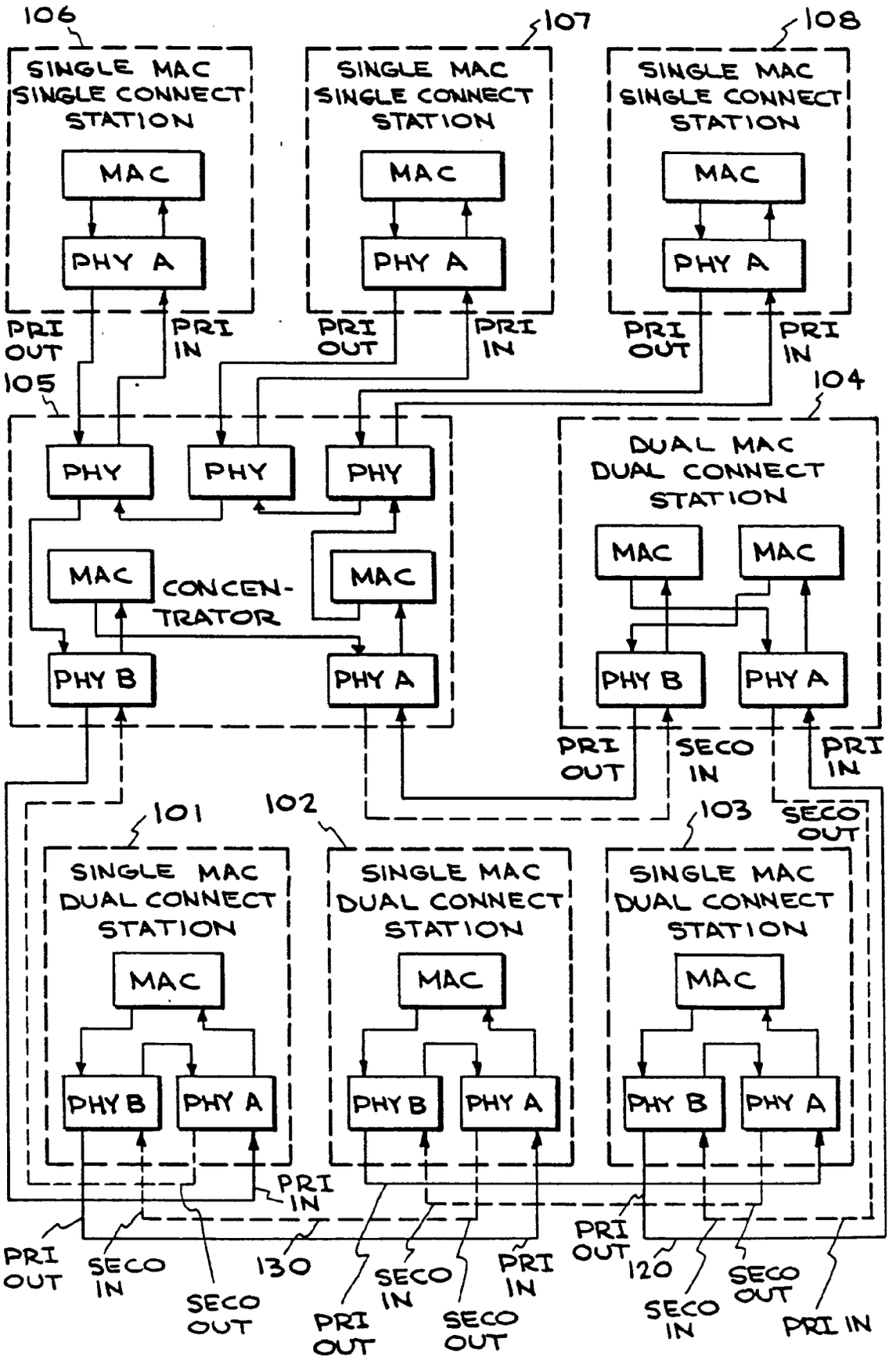

106
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
107
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
108
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
105
PHY
PHY
PHY
MAC
CONCEN-TRATOR
MAC
PHY B
PHY A
104
DUAL MAC DUAL CONNECT STATION
MAC
MAC
PHY B
PHY A
PRI OUT
SECO IN
PRI IN
SECO OUT
101
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
102
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
103
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
PRI IN
PRI OUT
SECO IN
SECO OUT
130
PRI OUT
SECO IN
SECO OUT
PRI IN
PRI OUT
120
SECO IN
SECO OUT
PRI IN
PRIMARY RING
SECONDARY RING

FIG. 1

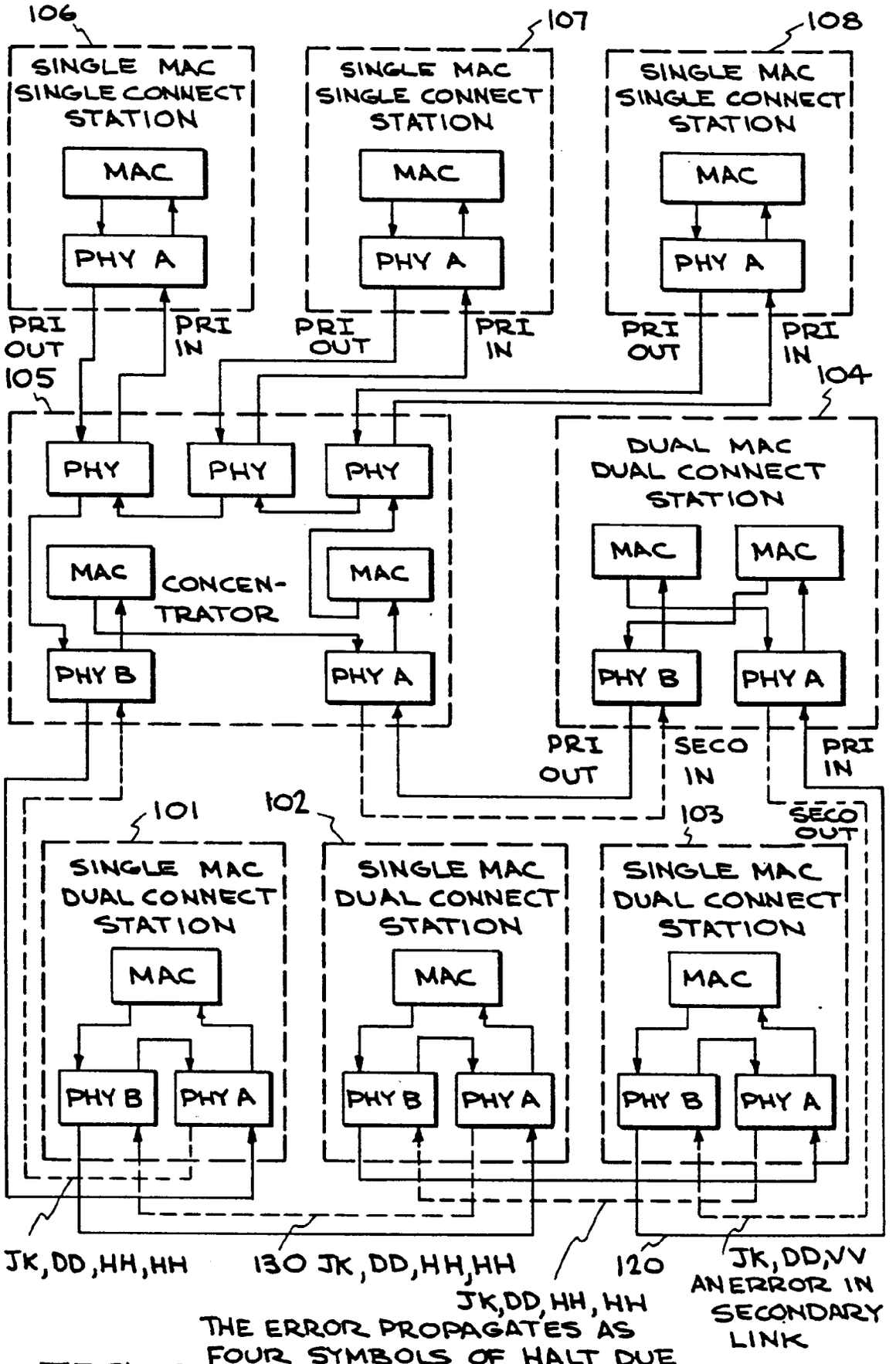

106
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
107
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
108
SINGLE MAC SINGLE CONNECT STATION
MAC
PHY A
PRI OUT
PRI IN
105
PHY
PHY
PHY
MAC
CONCEN-TRATOR
MAC
PHY B
PHY A
104
DUAL MAC DUAL CONNECT STATION
MAC
MAC
PHY B
PHY A
PRI OUT
SECO IN
PRI IN
SECO OUT
101
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
102
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
103
SINGLE MAC DUAL CONNECT STATION
MAC
PHY B
PHY A
JK,DD,HH,HH
130 JK,DD,HH,HH
120
JK,DD,HH,HH
JK,DD,VV
AN ERROR IN SECONDARY LINK
THE ERROR PROPAGATES AS FOUR SYMBOLS OF HALT DUE TO REPEAT FILTER ACTION IN PHY A

FIG. 2

FIG. 3A

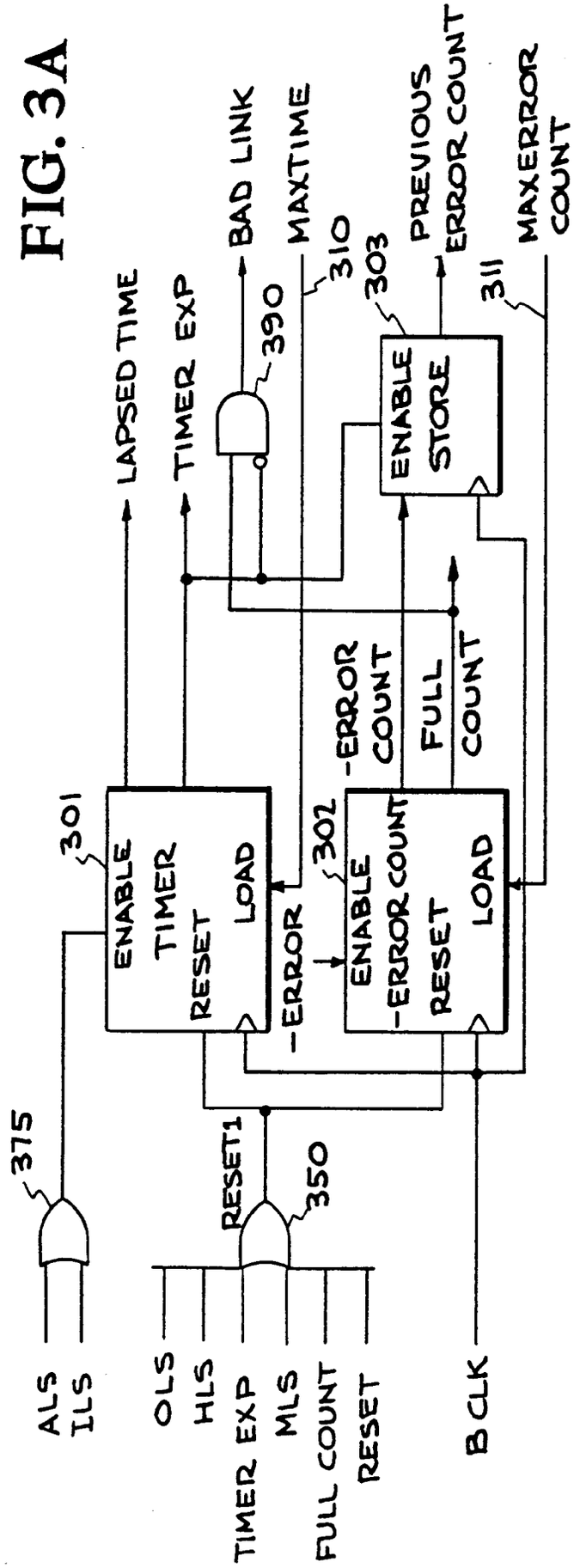
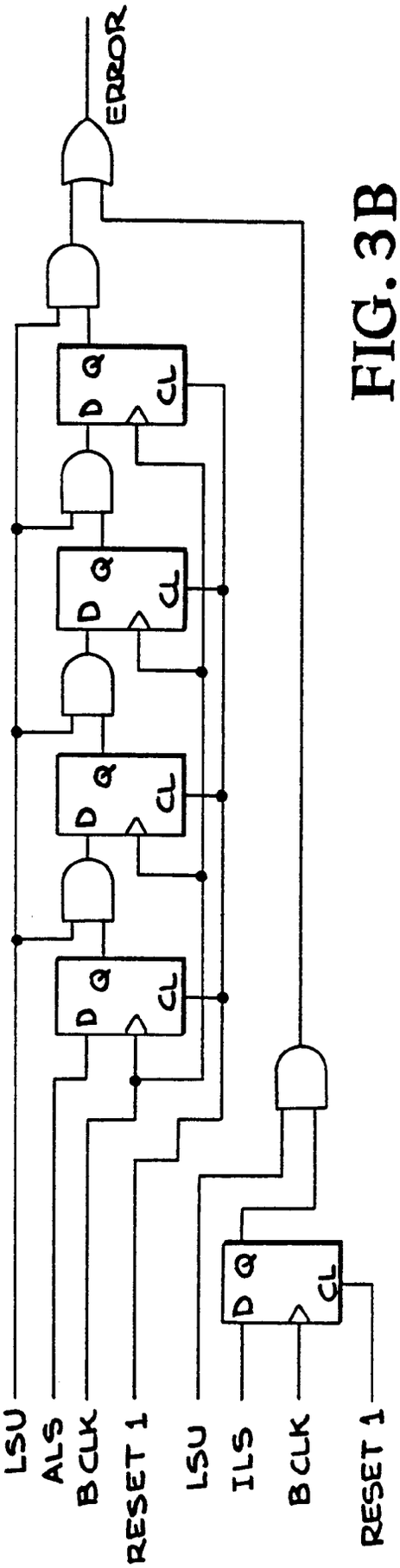

LAPSED TIME
TIMER EXP
BAD LINK
MAXTIME
310
390
303
PREVIOUS ERROR COUNT
311
MAXERROR COUNT
301
ENABLE TIMER RESET LOAD
302
ENABLE -ERROR COUNT RESET LOAD
-ERROR
-ERROR COUNT
FULL COUNT
375
350
RESET1
ALS
ILS
OLS
HLS
TIMER EXP
MLS
FULL COUNT
RESET
B CLK

FIG. 3B


ERROR
D Q CL
LSU
ALS
B CLK
RESET 1
LSU
ILS
B CLK
RESET 1

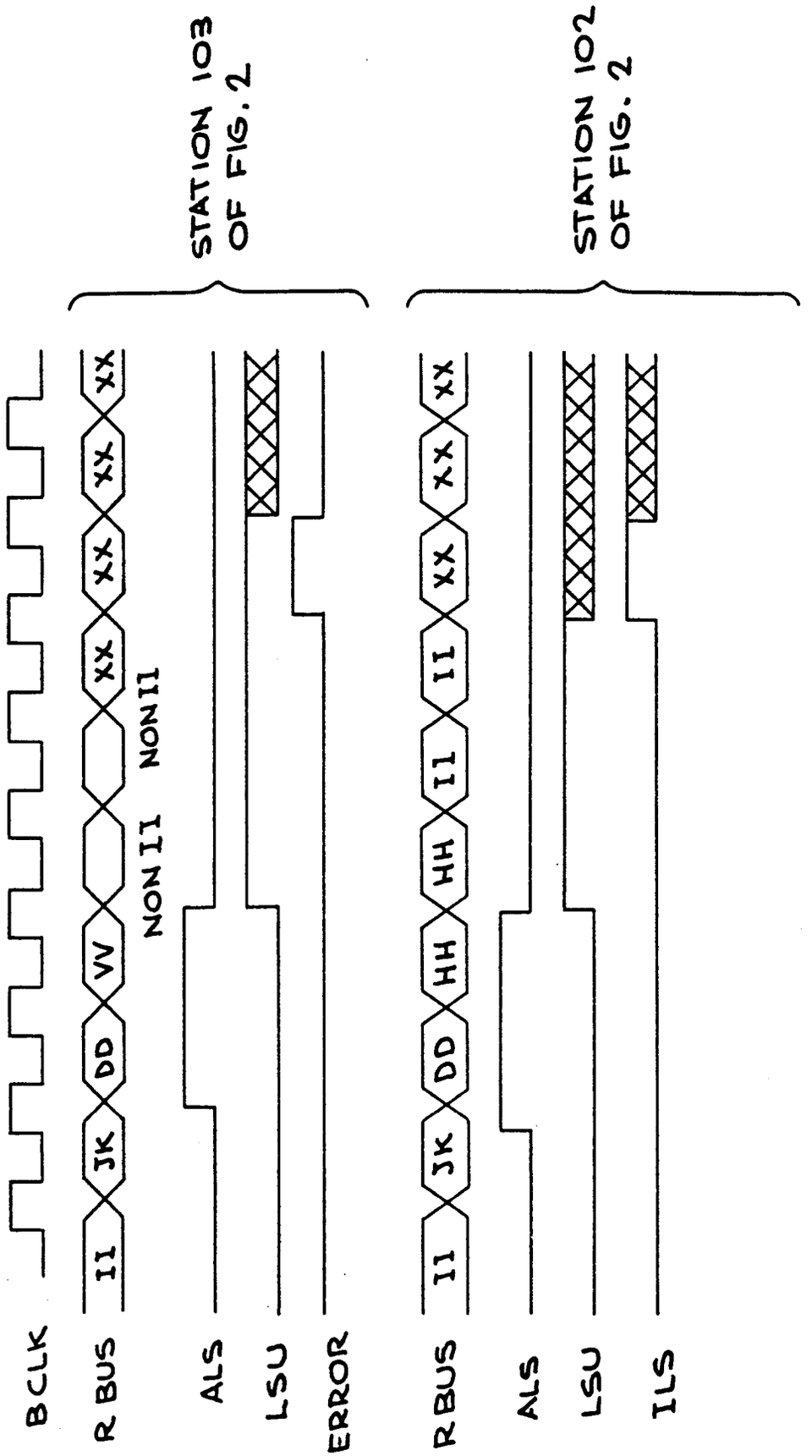

STATION 103
OF FIG. 2
STATION 102
OF FIG. 2
BCLK
R BUS
ALS
LSU
ERROR
R BUS
ALS
LSU
ILS
II
JK
DD
VV
XX
NON II
HH
I1

FIG. 4